

## 74F112 Dual JK Negative Edge-Triggered Flip-Flop

### General Description

The 74F112 contains two independent, high-speed JK flip-flops with Direct Set and Clear inputs. Synchronous state changes are initiated by the falling edge of the clock. Triggering occurs at a voltage level of the clock and is not directly related to the transition time. The J and K inputs can change when the clock is in either state without affecting the flip-flop, provided that they are in the desired state during the recommended setup and hold times relative to the falling edge of the clock. A LOW signal on  $\bar{S}_D$  or  $\bar{C}_D$  prevents clocking and forces Q or  $\bar{Q}$  HIGH, respectively.

Simultaneous LOW signals on  $\bar{S}_D$  and  $\bar{C}_D$  force both Q and  $\bar{Q}$  HIGH.

#### Asynchronous Inputs:

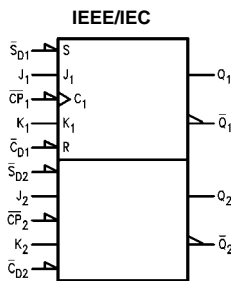
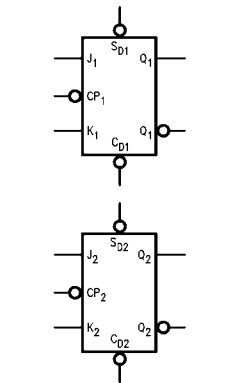
- LOW input to  $\bar{S}_D$  sets Q to HIGH level
- LOW input to  $\bar{C}_D$  sets Q to LOW level
- Clear and Set are independent of clock
- Simultaneous LOW on  $\bar{C}_D$  and  $\bar{S}_D$  makes both Q and  $\bar{Q}$  HIGH

### Ordering Code:

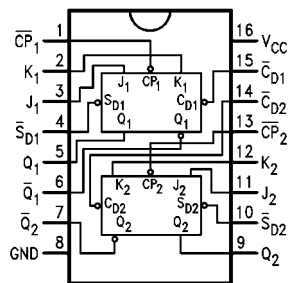
| Order Number | Package Number | Package Description   |
|--------------|----------------|---|
| 74F112SC     | M16A           | 16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow |
| 74F112SJ     | M16D           | 16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide               |
| 74F112PC     | N16E           | 16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide       |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

### Logic Symbols



### Connection Diagram



### Unit Loading/Fan Out

| Pin Names                                  | Description                              | U.L.<br>HIGH/LOW | Input $I_{IH}/I_{IL}$<br>Output $I_{OH}/I_{OL}$ |
|--|--|------------------|---|
| $J_1, J_2, K_1, K_2$                       | Data Inputs                              | 1.0/1.0          | 20 $\mu$ A/-0.6 mA                              |
| $\overline{CP}_1, \overline{CP}_2$         | Clock Pulse Inputs (Active Falling Edge) | 1.0/4.0          | 20 $\mu$ A/-2.4 mA                              |
| $\overline{CD}_1, \overline{CD}_2$         | Direct Clear Inputs (Active LOW)         | 1.0/5.0          | 20 $\mu$ A/-3.0 mA                              |
| $\overline{SD}_1, \overline{SD}_2$         | Direct Set Inputs (Active LOW)           | 1.0/5.0          | 20 $\mu$ A/-3.0 mA                              |
| $Q_1, Q_2, \overline{Q}_1, \overline{Q}_2$ | Outputs                                  | 50/33.3          | -1 mA/20 mA                                     |

### Truth Table

| Inputs          |                 |                 |   |   | Outputs          |                  |
|-----------------|-----------------|-----------------|---|---|------------------|------------------|
| $\overline{SD}$ | $\overline{CD}$ | $\overline{CP}$ | J | K | Q                | $\overline{Q}$   |
| L               | H               | X               | X | X | H                | L                |
| H               | L               | X               | X | X | L                | H                |
| L               | L               | X               | X | X | H                | H                |
| H               | H               | $\sim$          | h | h | $\overline{Q}_0$ | $Q_0$            |
| H               | H               | $\sim$          | l | h | L                | H                |
| H               | H               | $\sim$          | h | l | H                | L                |
| H               | H               | $\sim$          | l | l | $Q_0$            | $\overline{Q}_0$ |

H (h) = HIGH Voltage Level  
 L (l) = LOW Voltage Level  
 X = Immaterial

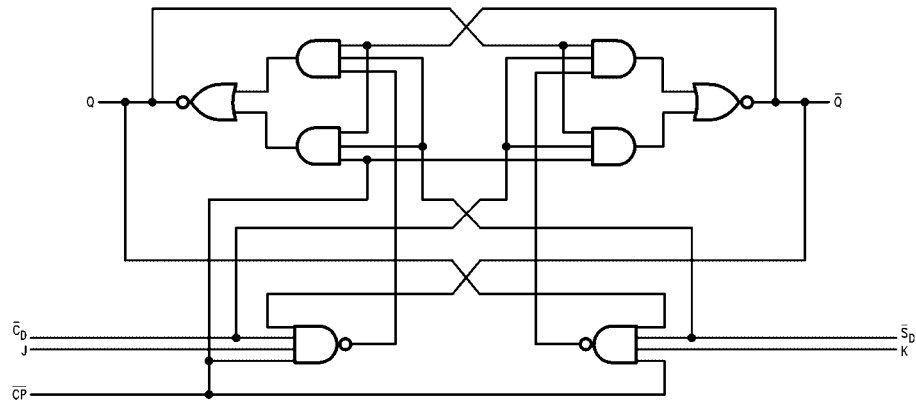
$\sim$  = HIGH-to-LOW Clock Transition

$Q_0(\overline{Q}_0)$  = Before HIGH-to-LOW Transition of Clock

Lower case letters indicate the state of the referenced input or output one setup time prior to the HIGH-to-LOW clock transition.

### Logic Diagram

(One Half Shown)



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

**Absolute Maximum Ratings**(Note 1)

|  |                                      |
|--|--------------------------------------|
| Storage Temperature  | -65°C to +150°C                      |
| Ambient Temperature under Bias   | -55°C to +125°C                      |
| Junction Temperature under Bias  | -55°C to +150°C                      |
| V <sub>CC</sub> Pin Potential to Ground Pin                            | -0.5V to +7.0V                       |
| Input Voltage (Note 2)   | -0.5V to +7.0V                       |
| Input Current (Note 2)   | -30 mA to +5.0 mA                    |
| Voltage Applied to Output<br>in HIGH State (with V <sub>CC</sub> = 0V) |                                      |
| Standard Output  | -0.5V to V <sub>CC</sub>             |
| 3-STATE Output   | -0.5V to +5.5V                       |
| Current Applied to Output<br>in LOW State (Max)                        | twice the rated I <sub>OL</sub> (mA) |

**Recommended Operating Conditions**

|                              |                |
|------------------------------|----------------|
| Free Air Ambient Temperature | 0°C to +70°C   |
| Supply Voltage               | +4.5V to +5.5V |

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

**Note 2:** Either voltage limit or current limit is sufficient to protect inputs.

**DC Electrical Characteristics**

| Symbol           | Parameter                         | Min                                       | Typ        | Max                  | Units | V <sub>CC</sub> | Conditions  |
|------------------|-----------------------------------|---|------------|----------------------|-------|-----------------|---|
| V <sub>IH</sub>  | Input HIGH Voltage                | 2.0                                       |            |                      | V     |                 | Recognized as a HIGH Signal   |
| V <sub>IL</sub>  | Input LOW Voltage                 |   |            | 0.8                  | V     |                 | Recognized as a LOW Signal  |
| V <sub>CD</sub>  | Input Clamp Diode Voltage         |   |            | -1.2                 | V     | Min             | I <sub>IN</sub> = -18 mA  |
| V <sub>OH</sub>  | Output HIGH Voltage               | 10% V <sub>CC</sub><br>5% V <sub>CC</sub> | 2.5<br>2.7 |                      | V     | Min             | I <sub>OH</sub> = -1 mA<br>I <sub>OH</sub> = -1 mA  |
| V <sub>OL</sub>  | Output LOW Voltage                | 10% V <sub>CC</sub>                       |            | 0.5                  | V     | Min             | I <sub>OL</sub> = 20 mA   |
| I <sub>IH</sub>  | Input HIGH Current                |   |            | 5.0                  | μA    | Max             | V <sub>IN</sub> = 2.7V  |
| I <sub>BVI</sub> | Input HIGH Current Breakdown Test |   |            | 7.0                  | μA    | Max             | V <sub>IN</sub> = 7.0V  |
| I <sub>CEX</sub> | Output HIGH Leakage Current       |   |            | 50                   | μA    | Max             | V <sub>OUT</sub> = V <sub>CC</sub>  |
| V <sub>ID</sub>  | Input Leakage Test                | 4.75                                      |            |                      | V     | 0.0             | I <sub>ID</sub> = 1.9 μA<br>All other pins grounded   |
| I <sub>OD</sub>  | Output Leakage Circuit Current    |   |            | 3.75                 | μA    | 0.0             | V <sub>IOD</sub> = 150 mV<br>All other pins grounded  |
| I <sub>IL</sub>  | Input LOW Current                 |   |            | -0.6<br>-2.4<br>-3.0 | mA    | Max             | V <sub>IN</sub> = 0.5V (J <sub>n</sub> , K <sub>n</sub> )<br>V <sub>IN</sub> = 0.5V (C <sub>Pn</sub> )<br>V <sub>IN</sub> = 0.5V (C <sub>Dn</sub> , S <sub>Dn</sub> ) |
| I <sub>OS</sub>  | Output Short-Circuit Current      | -60                                       |            | -150                 | mA    | Max             | V <sub>OUT</sub> = 0V   |
| I <sub>CCH</sub> | Power Supply Current              |   | 12         | 19                   | mA    | Max             | V <sub>O</sub> = HIGH   |
| I <sub>CCL</sub> | Power Supply Current              |   | 12         | 19                   | mA    | Max             | V <sub>O</sub> = LOW  |

### AC Electrical Characteristics

| Symbol           | Parameter  | T <sub>A</sub> = +25°C<br>V <sub>CC</sub> = +5.0V<br>C <sub>L</sub> = 50 pF |     |     | T <sub>A</sub> = 0°C to +70°C<br>V <sub>CC</sub> = +5.0V<br>C <sub>L</sub> = 50 pF |     | Units |
|------------------|--|---|-----|-----|--|-----|-------|
|                  |  | Min   | Typ | Max | Min  | Max |       |
| f <sub>MAX</sub> | Maximum Clock Frequency  | 85  | 105 |     | 80   |     | MHz   |
| t <sub>PLH</sub> | Propagation Delay  | 2.0   | 5.0 | 6.5 | 2.0  | 7.5 | ns    |
| t <sub>PHL</sub> | $\overline{CP}_n$ to Q <sub>n</sub> or $\overline{Q}_n$                          | 2.0   | 5.0 | 6.5 | 2.0  | 7.5 |       |
| t <sub>PLH</sub> | Propagation Delay  | 2.0   | 4.5 | 6.5 | 2.0  | 7.5 | ns    |
| t <sub>PHL</sub> | $\overline{C}_{Dn}$ , $\overline{S}_{Dn}$ to $\overline{Q}_n$ , $\overline{Q}_n$ | 2.0   | 4.5 | 6.5 | 2.0  | 7.5 |       |

### AC Operating Requirements

| Symbol            | Parameter  | T <sub>A</sub> = +25°C<br>V <sub>CC</sub> = +5.0V |     | T <sub>A</sub> = 0°C to +70°C<br>V <sub>CC</sub> = +5.0V |     | Units |
|-------------------|--|---|-----|--|-----|-------|
|                   |  | Min   | Max | Min  | Max |       |
| t <sub>S(H)</sub> | Setup Time, HIGH or LOW                                      | 4.0   |     | 5.0  |     | ns    |
| t <sub>S(L)</sub> | J <sub>n</sub> or K <sub>n</sub> to $\overline{CP}_n$        | 3.0   |     | 3.5  |     |       |
| t <sub>H(H)</sub> | Hold Time, HIGH or LOW                                       | 0   |     | 0  |     |       |
| t <sub>H(L)</sub> | J <sub>n</sub> or K <sub>n</sub> to $\overline{CP}_n$        | 0   |     | 0  |     |       |
| t <sub>W(H)</sub> | $\overline{CP}$ Pulse Width                                  | 4.5   |     | 5.0  |     | ns    |
| t <sub>W(L)</sub> | HIGH or LOW  | 4.5   |     | 5.0  |     |       |
| t <sub>W(L)</sub> | Pulse Width, LOW   | 4.5   |     | 5.0  |     | ns    |
| t <sub>W(L)</sub> | $\overline{C}_{Dn}$ or $\overline{S}_{Dn}$                   | 4.5   |     | 5.0  |     |       |
| t <sub>REC</sub>  | Recovery Time  | 4.0   |     | 5.0  |     | ns    |
| t <sub>REC</sub>  | $\overline{S}_{Dn}$ , $\overline{C}_{Dn}$ to $\overline{CP}$ | 4.0   |     | 5.0  |     |       |

**Physical Dimensions** inches (millimeters) unless otherwise noted



**16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow Package Number M16A**

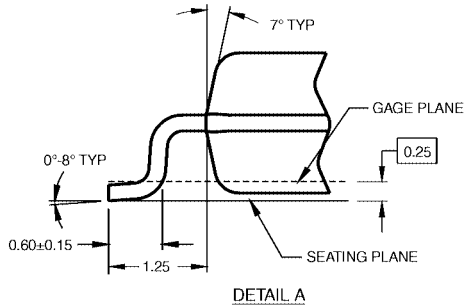
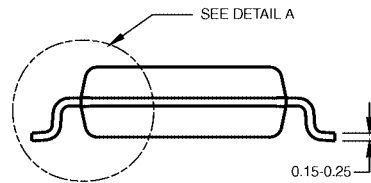
**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



DIMENSIONS ARE IN MILLIMETERS

- NOTES:  
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 B. DIMENSIONS ARE IN MILLIMETERS.  
 C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

M16DRevB1



**16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M16D**

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



**16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E**

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